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APPLICATION NO.	FILING DATE	FIRST NAMED INVENTOR	ATTORNEY DOCKET NO.	CONFIRMATION NO.
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10/711,081

08/20/2004

Dennis Scott Prince

5080

23971

7590

02/06/2006

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EXAMINER

BELLAMY, TAMIKO D

ART UNIT

PAPER NUMBER

2856

DATE MAILED: 02/06/2006

Please find below and/or attached an Office communication concerning this application or proceeding.

<b>Office Action Summary</b>	<b>Application No.</b> 10/711,081	<b>Applicant(s)</b> PRINCE, DENNIS SCOTT	
	<b>Examiner</b> Tamiko D. Bellamy	<b>Art Unit</b> 2856	

**-- The MAILING DATE of this communication appears on the cover sheet with the correspondence address --**  
**Period for Reply**

A SHORTENED STATUTORY PERIOD FOR REPLY IS SET TO EXPIRE 3 MONTH(S) OR THIRTY (30) DAYS, WHICHEVER IS LONGER, FROM THE MAILING DATE OF THIS COMMUNICATION.

- Extensions of time may be available under the provisions of 37 CFR 1.136(a). In no event, however, may a reply be timely filed after SIX (6) MONTHS from the mailing date of this communication.
- If NO period for reply is specified above, the maximum statutory period will apply and will expire SIX (6) MONTHS from the mailing date of this communication.
- Failure to reply within the set or extended period for reply will, by statute, cause the application to become ABANDONED (35 U.S.C. § 133). Any reply received by the Office later than three months after the mailing date of this communication, even if timely filed, may reduce any earned patent term adjustment. See 37 CFR 1.704(b).

#### Status

- 1) ☒ Responsive to communication(s) filed on 20 January 2006.
- 2a) ☐ This action is **FINAL**.                      2b) ☒ This action is non-final.
- 3) ☐ Since this application is in condition for allowance except for formal matters, prosecution as to the merits is closed in accordance with the practice under *Ex parte Quayle*, 1935 C.D. 11, 453 O.G. 213.

#### Disposition of Claims

- 4) ☒ Claim(s) 1-15, 17, 18 and 27 is/are pending in the application.
- 4a) Of the above claim(s) \_\_\_\_\_ is/are withdrawn from consideration.
- 5) ☒ Claim(s) 14, 15, 17, and 18 is/are allowed.
- 6) ☒ Claim(s) 1-4, 10, 12 and 27 is/are rejected.
- 7) ☒ Claim(s) 5-9, 11 and 13 is/are objected to.
- 8) ☐ Claim(s) \_\_\_\_\_ are subject to restriction and/or election requirement.

#### Application Papers

- 9) ☐ The specification is objected to by the Examiner.
- 10) ☒ The drawing(s) filed on 1/20/06 is/are: a) ☒ accepted or b) ☐ objected to by the Examiner.  
Applicant may not request that any objection to the drawing(s) be held in abeyance. See 37 CFR 1.85(a).  
Replacement drawing sheet(s) including the correction is required if the drawing(s) is objected to. See 37 CFR 1.121(d).
- 11) ☒ The oath or declaration is objected to by the Examiner. Note the attached Office Action or form PTO-152.

#### Priority under 35 U.S.C. § 119

- 12) ☐ Acknowledgment is made of a claim for foreign priority under 35 U.S.C. § 119(a)-(d) or (f).
- a) ☐ All    b) ☐ Some \* c) ☐ None of:
1. ☐ Certified copies of the priority documents have been received.
  2. ☐ Certified copies of the priority documents have been received in Application No. \_\_\_\_\_.
  3. ☐ Copies of the certified copies of the priority documents have been received in this National Stage application from the International Bureau (PCT Rule 17.2(a)).

\* See the attached detailed Office action for a list of the certified copies not received.

#### Attachment(s)

- |  |   |
|--|---|
| 1) <input checked="" type="checkbox"/> Notice of References Cited (PTO-892)  | 4) <input type="checkbox"/> Interview Summary (PTO-413)<br>Paper No(s)/Mail Date. _____ |
| 2) <input type="checkbox"/> Notice of Draftsperson's Patent Drawing Review (PTO-948)                                   | 5) <input type="checkbox"/> Notice of Informal Patent Application (PTO-152)             |
| 3) <input type="checkbox"/> Information Disclosure Statement(s) (PTO-1449 or PTO/SB/08)<br>Paper No(s)/Mail Date _____ | 6) <input type="checkbox"/> Other: _____  |

## DETAILED ACTION

### *Oath/Declaration*

1. It does not identify the citizenship or contain a signature of each inventor.

### *Drawings*

2. The drawings were received on 1/20/06. These drawings are accepted.

### *Claim Rejections - 35 USC § 102*

3. The following is a quotation of the appropriate paragraphs of 35 U.S.C. 102 that form the basis for the rejections under this section made in this Office action:

A person shall be entitled to a patent unless –

(b) the invention was patented or described in a printed publication in this or a foreign country or in public use or on sale in this country, more than one year prior to the date of application for patent in the United States.

4. Claims 1-4, 10, 12, and 27 are rejected under 35 U.S.C. 102(b) as being anticipated by Cobb (5,604,299).

Re claim 1, as depicted in figs. 1 and 2, Cobb discloses positioning a sensor array of emission sensors (e.g., measuring stations A-F) in spaced relation at fixed location about a facility, and monitoring the emission readings from the sensors (A-F) and a direction of those increased emissions (Col. 3, lines 11-54). As depicted in fig. 2, Cobb discloses performing a spatial temporal emission concentration analysis to identify the source of emissions (e.g., average concentration point P) where the source of emissions is considered as a centroid and lines drawn from the sensors detecting increased emissions in the direction of the increased emissions are assumed to cross at the source of emissions (e.g., average concentration point P) (Col. 4, lines 47-68; Col. 5, lines 10).

Re claim 2, as depicted in fig. 2, Cobb discloses the sensor array of emission sensors (e.g., measurement stations (A-F)) at fixed locations. Cobb discloses that the concentration information may be obtained by any convenient method (Col. 3, lines 26-37), which is equivalent to using emission sensors that are portable.

Re claim 3, as depicted in fig. 2, Cobb discloses positioning a sensor array of emission sensors (e.g., measurement stations A-F) at fixed locations about a facility. Cobb discloses monitoring changes in emission readings from the sensors, and performing a spatial temporal emission concentration analysis to identify the source of emissions.

Re claim 4, Cobb discloses that the concentration information may be obtained by any convenient method (Col. 3, lines 26-37), which is equivalent to using emission sensors that are electrochemical sensors.

Re claim 10, Cobb discloses filtering data readings associated with certain conditions such as wind speed, wind direction, or concentration (Col. 4, lines 39-42), which is equivalent to using emission specific filters to isolate the sensor sensitivity to emissions of interest.

Re claim 12, as depicted in fig. 2, Cobb discloses multiple sensors (e.g., measurement stations A-F). Cobb discloses that the concentration information may be obtained by any convenient method. Cobb discloses that a gas/liquid chromatography may be used because of its sensitivity to many types of pollutants (Col. 3, lines 26-37), which is equivalent to multiple sensors tuned to measure different gases.

Re claim 27, as depicted in figs. 1 and 2, Cobb discloses taking emission readings with sensors (e.g., measuring stations A-F) from a plurality of locations about a facility, and monitoring the emission readings from the sensors (A-F) and a direction of those increased emissions (Col. 3, lines 11-54). As depicted in fig. 2, Cobb discloses performing a spatial temporal emission concentration analysis to identify the source of emissions (e.g., average concentration point P) where the source of emissions is considered as a centroid and lines drawn from the sensors detecting increased emissions in the direction of the increased emissions are assumed to cross at the source of emissions (e.g., average concentration point P) (Col. 4, lines 47-68; Col. 5, lines 10).

5. Claims 1, 3, and 27 are rejected under 35 U.S.C. 102(b) as being anticipated by Iwashige et al. (JP11118701A).

Re claim 1, as depicted in figs. 1 and 2, Iwashige et al. discloses positioning a sensor array of emission sensors (e.g., detecting means 1-3) in spaced relation at fixed location about a facility, and monitoring the emission readings from the sensors (e.g., detecting means 1-3) and a direction of those increased emissions (Col. 3, lines 11-54). As depicted in fig. 2, Iwashige et al. discloses performing a spatial temporal emission concentration analysis to identify the source of emissions (e.g., emission point 5) where the source of emissions is considered as a centroid and lines drawn from the sensors (1-3) detecting increased emissions in the direction of the increased emissions are assumed to cross at the source of emissions (e.g., emission point 5) (Par. 18).

Re claim 3, as depicted in fig. 2, Iwashige et al. discloses positioning a sensor array of emission sensors (e.g., detecting means 1-3) at fixed locations about a facility.

Iwashige et al. discloses monitoring changes in emission readings from the sensors, and performing a spatial temporal emission concentration analysis to identify the source of emissions.

Re claim 27, as depicted in figs. 1 and 2, Iwashige et al. discloses taking emission readings with sensors (e.g., detecting means 1-3) from a plurality of locations about a facility, and monitoring the emission readings from the sensors (1-3) and the direction of those increased emissions. As depicted in fig. 2, Iwashige et al. discloses performing a spatial temporal emission concentration analysis to identify the source of emissions (e.g., emission point 5) where the source of emissions is considered as a centroid and lines drawn from the sensors detecting increased emissions in the direction of the increased emissions are assumed to cross at the source of emissions (e.g., emission point 5) (Par. 18).

### ***Claim Rejections - 35 USC § 103***

6. The following is a quotation of 35 U.S.C. 103(a) which forms the basis for all obviousness rejections set forth in this Office action:

(a) A patent may not be obtained though the invention is not identically disclosed or described as set forth in section 102 of this title, if the differences between the subject matter sought to be patented and the prior art are such that the subject matter as a whole would have been obvious at the time the invention was made to a person having ordinary skill in the art to which said subject matter pertains. Patentability shall not be negated by the manner in which the invention was made.

7. Claims 2, 4, 10, and 12 are rejected under 35 U.S.C. 103(a) as being unpatentable over Iwashige et al. (JP11118701A) in view of Cobb (5,604,299).

Re claim 2, as depicted in fig. 2, Iwashige et al discloses the sensor array of emission sensors (e.g., detection means 1-3) at fixed locations. Iwashige et al. lacks the detail of supplementing the sensors array with portable sensors. However, the court held in In re Lindberg, 194 F.2d 732, 93 USPQ 23 (CCPA 1952), that providing portability to a prior art device is a design consideration within the skill of the art. Furthermore, Cobb discloses that the concentration information may be obtained by **any convenient method** (Col. 3, lines 26-37), which is equivalent to using emission sensors that are portable. Therefore, to modify Iwashige et al. by employing portable sensors would have been obvious to one of ordinary skill in the art at the time of the invention since Cobb teaches a device having theses design characteristics. The skilled artisan would be motivated to combine the teachings of Iwashige et al. and Cobb since Iwashige et al. states that his invention is applicable to locating an emission source/point and Cobb is directed to locating emission sources.

Re claim 4, Iwashige et al. discloses a plurality of emission sensors (e.g., detections means 1-3) for detecting concentrations. Iwashige et al. lacks the detail of the sensors being electrochemical sensors. Cobb discloses that the concentration information may be obtained by any convenient method (Col. 3, lines 26-37), which is equivalent to using emission sensors that are electrochemical sensors. Therefore, to modify Iwashige et al. by employing electrochemical sensors would have been obvious to one of ordinary skill in the art at the time of the invention since Cobb teaches a device having theses design characteristics. The skilled artisan would be motivated to combine the teachings

of Iwashige et al. and Cobb since Iwashige et al. states that his invention is applicable to locating an emission source/point and Cobb is directed to locating emission sources.

Re claim 10, Iwashige et al. discloses a plurality of emission sensors (e.g., detecting means 1-3). Iwashige et al. lacks the detail of using emission specific filters. Cobb discloses filtering data readings associated with certain conditions such as wind speed, wind direction, or concentration (Col. 4, lines 39-42), which is equivalent to using emission specific filters to isolate the sensor sensitivity to emissions of interest. Therefore, to modify Iwashige et al. by employing using emission specific filters would have been obvious to one of ordinary skill in the art at the time of the invention since Cobb teaches a device having these design characteristics. The skilled artisan would be motivated to combine the teachings of Iwashige et al. and Cobb since Iwashige et al. states that his invention is applicable to locating an emission source/point and Cobb is directed to locating emission sources.

Re claim 12, Iwashige et al. discloses a plurality of emission sensors (e.g., detecting means 1-3) measuring concentrations. Iwashige et al. lacks the detail of the multiple sensors tuned to measure different gases. As depicted in fig. 2, Cobb discloses multiple sensors (e.g., measurement stations A-F). Cobb discloses that the concentration information may be obtained by any convenient method. Cobb discloses that a gas/liquid chromatography may be used because of its sensitivity to many types of pollutants (Col. 3, lines 26-37), which is equivalent to multiple sensors tuned to measure different gases. Therefore, to modify Iwashige et al. by employing sensors tuned to measure different gases would have been obvious to one of ordinary skill in the art at the time of the



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invention since Cobb teaches a device having these design characteristics. The skilled artisan would be motivated to combine the teachings of Iwashige et al. and Cobb since Iwashige et al. states that his invention is applicable to locating an emission source/point and Cobb is directed to locating emission sources.

*Allowable Subject Matter*

8. Claims 5-9, 11, 13 are objected to as being dependent upon a rejected base claim, but would be allowable if rewritten in independent form including all of the limitations of the base claim and any intervening claims.

9. Claims 14, 15, 17, and 18 are allowed.

The following is a statement of reasons for the indication of allowable subject matter:

Re claim 14, the independent claim includes “ the sensor array including redundant sensors to improve accuracy and identify sensors with erroneous readings “ in combination with the remaining claim limitation is not taught and/or made obvious by the prior art. Cobb and Iwashige et al., considered closest to related art, each teach emission sensors in spaced relation at fixed locations about a facility, neither Cobb nor Iwashige et al. teaches **a sensor array including redundant sensors to improve accuracy and identify sensors with erroneous readings.**

*Response to Remarks*

10. Applicant's arguments with respect to claims 1, 2, 4-10, 12, 14, 15, and 17 have been considered but are moot in view of the new ground(s) of rejection. It is the examiners position

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that claims 1-4, 10, 12, and 27 are not patentable in view of the newly applied art of Cobb (5,604,299). It is the examiners position that claims 1, 3, and 27 are not patentable in view of the newly applied art of Iwashige et al. (JP11118701A); and claims 2, 4, 10, and 12 are not patentable in view of the newly applied art of Iwashige et al. (JP11118701A) in view of Cobb (5,604,299).

***Conclusion***

11. Any inquiry concerning this communication or earlier communications from the examiner should be directed to Tamiko D. Bellamy whose telephone number is (571) 272-2190. The examiner can normally be reached on Monday - Friday 7:30 AM to 3:30 PM.

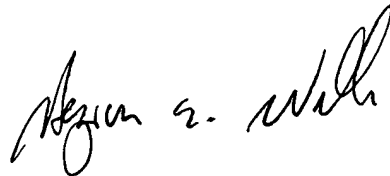
If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, Hezron Williams can be reached on (571) 272-2208. The fax phone number for the organization where this application or proceeding is assigned is 571-273-8300.

Information regarding the status of an application may be obtained from the Patent Application Information Retrieval (PAIR) system. Status information for published applications may be obtained from either Private PAIR or Public PAIR. Status information for unpublished applications is available through Private PAIR only. For more information about the PAIR system, see <http://pair-direct.uspto.gov>. Should you have questions on access to the Private PAIR system, contact the Electronic Business Center (EBC) at 866-217-9197 (toll-free).

Tamiko Bellamy

T.B.  
January 26, 2006

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A handwritten signature in black ink, appearing to read "Hezron Williams", with a long, sweeping horizontal line extending to the right.

HEZRON WILLIAMS  
SUPERVISORY PATENT EXAMINER  
TECHNOLOGY CENTER 2800